## Application/Control No. Applicant(s)/Patent Under Reexamination 10/701,541 STEK ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Thang V. Tran 2653 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-6,345,023 Α 02-2002 Fushimi et al. 369/47.36 В US-US-С D US-Ε US-US-F G US-USн USı US-J US-Κ US-L US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Classification Name Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.